



Standard Test Method for Determining the Insulation Resistance of a Membrane Switch¹

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1. Scope

1.1 This test method covers the determination of the insulation resistance of a membrane switch.

1.2 *This standard does not purport to address all of the safety concerns, if any, associated with its use. It is the responsibility of the user of this standard to establish appropriate safety and health practices and determine the applicability of regulatory limitations prior to use.*

2. Terminology

2.1 Definitions:

2.1.1 *insulation resistance*—the electrical resistance between test points.

2.1.2 *leakage current*—current flow through the insulation between test points.

2.1.3 *membrane switch*—a momentary switching device in which at least one contact is on, or made of, a flexible substrate.

2.1.4 *test points*—two preselected conductive points in a circuit loop, possibly including a switch.

3. Significance and Use

3.1 Insulation resistance is useful for design verification, quality control of materials, and workmanship.

3.2 Low insulation resistance can cause high leakage currents.

3.3 High leakage currents can lead to deterioration of the insulation or false triggering of the associated input device, or both.

3.4 Specific areas of testing are, but not limited to:

3.4.1 Conductor/dielectric/conductor crossing point.

3.4.2 Close proximity of conductors, and

3.4.3 Any other conductive surface such as shielding or metal backing panel.

¹ This test method is under the jurisdiction of ASTM Committee F01 on Electronics and is the direct responsibility of Subcommittee F01.18 on Membrane Switches.

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3.5 Insulation resistance measurement may be destructive and units that have been tested should be considered unreliable for future use.

4. Interferences

4.1 The following parameters may affect the result of this test:

4.1.1 Humidity,

4.1.2 Contamination,

4.1.3 Barometric pressure, and

4.1.4 Temperature.

5. Apparatus

5.1 *Electric Device*, suitable to provide a constant preselected dc voltage and suitable electronic monitoring device to measure very small current levels (micro-ampere range), or

5.2 *Resistance Measuring Device*, such as a megohm-meter, or equivalent that can provide a specified voltage. (This would replace 5.1.)

6. Procedure—Voltage Source Method (Fig. 1)

6.1 Pretest Setup:

6.1.1 Connect test points of the switch assembly to the voltage source.

6.1.2 Connect leakage current measuring device in series with the voltage source.

6.2 In-Process Test:

6.2.1 Adjust voltage source to 100 VDC \pm 10 % or as specified.

6.2.2 Dwell for 60 s.

6.2.3 Record leakage current.

7. Procedure—Megohm Method (Fig. 2)

7.1 Pretest Setup:

7.1.1 Connect test points of the switch assembly to the megohm-meter.

7.2 In-Process Test:

7.2.1 Adjust megohm-meter to 100 VDC \pm 10 % or as specified.

7.2.2 Dwell for 60 s.

7.2.3 Record insulation resistance.

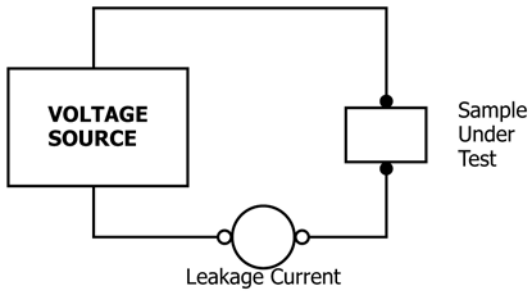


FIG. 1 Test Setup Option



FIG. 2 Test Setup Option

8. Calculations—Voltage Source Method Only

8.1 Calculate the insulation resistance as follows:

$$\text{Insulation Resistance} = \text{Applied Voltage} / \text{Leakage Current}$$

9. Report

9.1 Report the following information:

- 9.1.1 Temperature,
- 9.1.2 Humidity,
- 9.1.3 Barometric pressure,
- 9.1.4 Applied voltage,
- 9.1.5 Duration of applied voltage,
- 9.1.6 Leakage Current—Voltage Source Method only,
- 9.1.7 Insulation resistance,
- 9.1.8 Part number or description of switch, or both,
- 9.1.9 Description of test points,
- 9.1.10 Date of test, and
- 9.1.11 Description of all equipment used (including sensitivity range).

10. Precision and Bias

10.1 The precision and bias of this test method are under investigation.

11. Keywords

11.1 insulation resistance; leakage current; membrane switch

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